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Optical fibres - Part 1-20: Measurement methods and test procedures - Fibre geometry

Táto norma obsahuje anglickú verziu európskej normy. This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 07/15

Obsahuje: EN 60793-1-20:2014, IEC 60793-1-20:2014

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# EN 60793-1-20

**EUROPÄISCHE NORM** 

November 2014

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**English Version** 

# Optical fibres - Part 1-20: Measurement methods and test procedures - Fibre geometry (IEC 60793-1-20:2014)

Fibres optiques - Partie 1-20: Méthodes de mesure et procédures d'essai - Géométrie de la fibre (CEI 60793-1-20:2014) Lichtwellenleiter - Teil 1-20: Messmethoden und Prüfverfahren - Fasergeometrie (IEC 60793-1-20:2014)

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## Foreword

The text of document 86A/1562/CDV, future edition 1 of IEC 60793-1-20, prepared by SC 86A "Fibres and cables" of IEC/TC 86 "Fibre optics" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60793-1-20:2014.

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- latest date by which the document has to be implemented at (dop) 2015-08-14 national level by publication of an identical national standard or by endorsement
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# Annex ZA

# (normative)

# Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

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Publication	<u>Year</u>	Title	<u>EN/HD</u>	Year
IEC 60793-2-10	-	Optical fibres - Part 2-10: Product specifications - Sectional specification for category A1 multimode fibres	EN 60793-2-10	-
IEC 60793-2-20	-	Optical fibres - Part 2-20: Product specifications - Sectional specification for category A2 multimode fibres	EN 60793-2-20	-
IEC 60793-2-30	-	Optical fibres - Part 2-30: Product specifications - Sectional specification for category A3 multimode fibres	EN 60793-2-30	-
IEC 60793-2-40	-	Optical fibres - Part 2-40: Product specifications - Sectional specification for category A4 multimode fibres	EN 60793-2-40	-
IEC 60793-2-50	-	Optical fibres - Part 2-50: Product specifications - Sectional specification for class B single- mode fibres	EN 60793-2-50	-
IEC 60793-2-60	-	Optical fibres - Part 2-60: Product specifications - Sectional specification for category C single-mode intraconnection fibres	EN 60793-2-60	-
IEC 61745	-	End-face image analysis procedure for the calibration of optical fibre geometry test sets	-	-



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# INTERNATIONAL STANDARD

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Optical fibres – Part 1-20: Measurement methods and test procedures – Fibre geometry

Fibres optiques – Partie 1-20: Méthodes de mesure et procédures d'essai – Géométrie de la fibre





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### INTERNATIONAL ELECTROTECHNICAL COMMISSION

# OPTICAL FIBRES -

## Part 1-20: Measurement methods and test procedures – Fibre geometry

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International Standard IEC 60793-1-20 has been prepared by subcommittee SC86A: Fibre and cables, of IEC technical committee TC86: Fibre optics.

This second edition cancels and replaces the first edition, published in 2001, and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- the reference test method for all fibre types is changed to the video grey scale transmitted near field method from the refracted near field method;
- the test lengths for all fibre types are now to be specified in the fibre's detail specification;
- the core illumination wavelength for all multimode fibre types may now to be specified in the fibre's detail specification although defaults are given;

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- the core *k*-factor (decision level) is now to be specified in the detail specification for all multimode fibre types;
- this edition is substantially more specific in describing the measurement; data reduction and transformation is fully described;
- the data reduction methodology for both refracted near-field and transmitted near-field methods are now unified and consistent.

The text of this standard is based on the following documents:

CDV	Report on voting
86A/1562/CDV	86A/1623/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60793 series, published under the general title *Optical fibres*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

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# INTRODUCTION

This standard gives two methods for measuring fibre geometry characteristics:

- Method A: Refracted near-field, described in Annex A;
- Method B: Transmitted near-field, described in Annex B.

Methods A and B apply to the geometry measurement of all class A multimode fibres, class B single-mode fibres and class C single-mode interconnection fibres. The fibre's applicable product specifications, IEC 60793-2-10, IEC 60793-2-20, IEC 60793-2-30, IEC 60793-2-40, IEC 60793-2-50 and IEC 60793-2-60, provide relevant measurement details, including sample lengths and *k* factors.

The geometric parameters measurable by the methods described in this standard are as follows:

- cladding diameter;
- cladding non-circularity;
- core diameter (class A fibre only);
- core non-circularity (class A fibre only);
- core-cladding concentricity error.

NOTE 1 The core diameter of class B and class C fibres is not specified. The equivalent parameter is mode field diameter, determined by IEC 60793-1-45.

NOTE 2 These methods specify both one-dimensional (1-D) and two-dimensional (2-D) data collection techniques and data analyses. The 1-D methods by themselves cannot detemine non-circularity nor concentricity error. When non-circular bodies are measured with 1-D methods, body diameters suffer additional uncertainties. These limitations may be overcome by scanning and analysing multiple 1-D data sets. Clause 5 provides further information.

Information common to both methods appears in Clauses 2 through 10, and information pertaining to each individual method appears in Annexes A and B, respectively. Annex C describes normative methods used to find the optical boundaries of the core and the cladding, Annex D describes normative procedures to fit ellipses to sets of detected boundaries. Annex E provides an informative fitting procedure of power-law models to graded-index core profiles. Annex F describes an informative methodology relating to the transformation of core diameter measurements determined with methods other than the reference method to approximate reference method values.

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# **OPTICAL FIBRES** –

# Part 1–20: Measurement methods and test procedures – Fibre geometry

### 1 Scope

This part of IEC 60793 establishes uniform requirements for measuring the geometrical characteristics of uncoated optical fibres.

The geometry of uncoated optical fibres directly affect splicing, connectorization and cabling and so are fundamental parameters requiring careful specification, quality control, and thus measurement.

### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60793-2-10, Optical fibres – Part 2-10: Product specifications – Sectional specification for category A1 multimode fibres

IEC 60793-2-20, Optical fibres – Part 2-20: Product specifications – Sectional specification for category A2 multimode fibres

IEC 60793-2-30, Optical fibres – Part 2-30: Product specifications – Sectional specification for category A3 multimode fibres

IEC 60793-2-40, Optical fibres – Part 2-40: Product specifications – Specification for category A4 multimode fibres

IEC 60793-2-50, Optical fibres – Part 2-50: Product specifications – Sectional specification for class B single-mode fibres

IEC 60793-2-60, Optical fibres – Part 2-60: Product specifications – Sectional specification for category C single-mode intraconnection fibres

IEC 61745, End-face image analysis procedure for the calibration of optical fibre geometry test sets

# koniec náhľadu – text ďalej pokračuje v platenej verzii STN